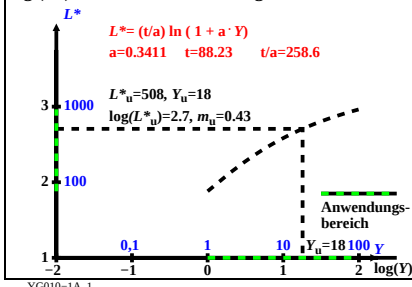
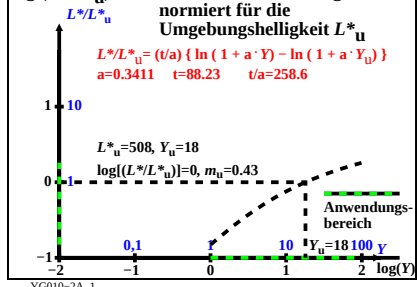


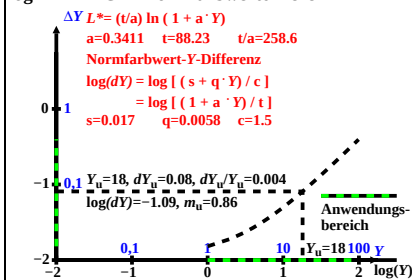
log (L*) LABJND Musterhelligkeit



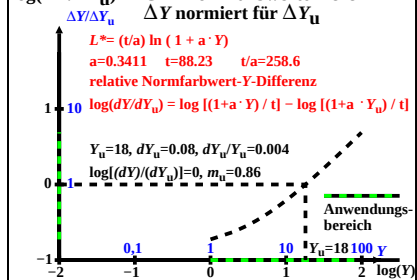
log (L*/L*_u) LABJND Musterhelligkeit L* normiert für die Umgebungshelligkeit L*_u



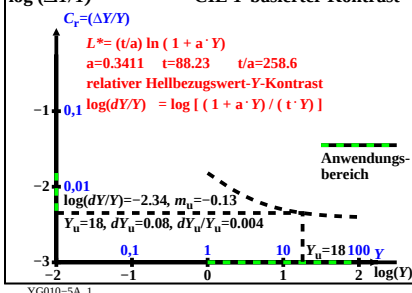
log ΔY CIE-Normfarbwertdifferenz ΔY



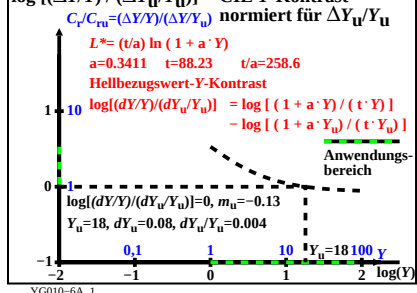
log(ΔY/ΔY_u) CIE-Normfarbwertdifferenz ΔY normiert für ΔY_u



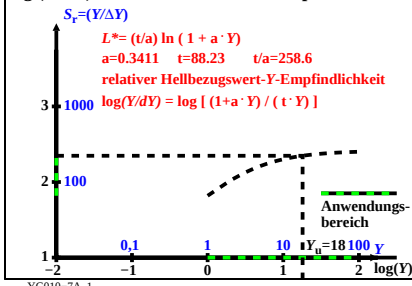
log (ΔY/Y) CIE Y-basierter Kontrast C_r=(ΔY/Y)



log [(ΔY/Y) / (ΔY_u/Y_u)] CIE Y-Kontrast C_r/C_u=(ΔY/Y)/(ΔY_u/Y_u) normiert für ΔY_u/Y_u



log (Y/ΔY) CIE Y-basierte Empfindlichkeit S_r=(Y/ΔY)



log [(Y/ΔY) / (Y_u/ΔY_u)] CIE Y-Empfindlichkeit S_r/S_u=(Y/ΔY)/(Y_u/ΔY_u) normiert für Y_u/ΔY_u

